

Data sheet acquired from Harris Semiconductor SCHS062B – Revised July 2003

# CMOS Binary Rate Multiplier

High-Voltage Types (20-Volt Rating)

rate multiplier that provides an output pulse rate multiplier that provides an output pulse rate that is the clock-input-pulse rate multiplied by 1/16 times the binary input. For example, when the binary input number is 13, there will be 13 output pulses for every 16 input pulses. This device may be used in conjunction with an up/down counter and control logic used to perform arithmetic operations (adds, subtract, divide, raise to a power), solve algebraic and differential equations, generate natural logarithms and trigometric functions, A/D and D/A conversions, and frequency division.

For words of more than 4 bits, CD4089B devices may be cascaded in two different modes: an Add mode and a Multiply mode (see Figs. 14 and 15). In the Add mode some of the gaps left by the more significant unit at the count of 15 are filled in by the less significant units. For example, when two units are cascaded in the Add mode and programmed to 11 and 13, respectively, the more significant unit will have 11 output pulses for every 16 input pulses and the other unit will have 13 output pulses for every 256 input pulses for a total of

 $\frac{11}{16} + \frac{13}{256} = \frac{189}{256}$ 

In the Multiply mode the fraction programmed into the first rate multiplier is multiplied by the fraction programmed into the second multiplier. Thus the output rate will be 11 13 143

16 16 256

#### Features:

- Cascadable in: multiples of 4-bits
- Set to "15" input and "15" detect output
- 100% tested for quiescent current at 20 V
- 5-V, 10-V, and 15-V parametric ratings
- Standardized, symmetrical output characteristics
- Maximum input current of 1 μA at 18 V over full package-temperature range; 100 nA at 18 V and 25°C
- Noise margin (full package-temperature range) =

1 V at V<sub>DD</sub> = 5 V 2 V at V<sub>DD</sub> = 10 V 2.5 V at V<sub>DD</sub> = 15 V

Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"

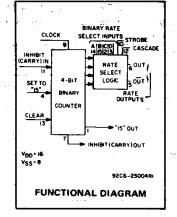
#### Applications:

- Numerical control
- Instrumentation
- Digital filtering
- Frequency synthesis

The CD4089B has an internal synchronous 4-bit counter which, together with one of the four binary input bits, produces pulse trains as shown in Fig. 2.

If more than one binary input bit is high, the resulting pulse train is a combination of the separate pulse trains as shown in Fig. 2.

The CD4089B types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (NSR suffix), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).



CD4089B Types

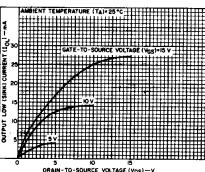


Fig. 1 — Typical output low (sink) current characteristics.

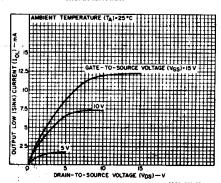


Fig. 2 - Minimum output low (sink) current characteristics.

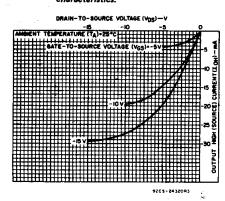


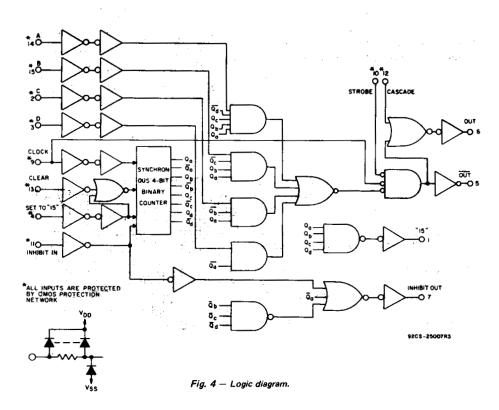
Fig. 3 — Typical output high (source) current characteristics.

MAXIMUM RATINGS, Absolute-Maximum Values: DC SUPPLY-VOLTAGE RANGE, (VDD)

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RECOMMENDED OPERATING CONDITIONS at  $T_A = 25^{\circ}$ C, Except as Noted. For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC		V <sub>DD</sub>	LIÑ	IITS	UNITS
	·	(V)	Min.	Max.	
Supply-Voltage Range (For TA Temperature Range)	= Full Package-		3	18	٧
Set or Clear Pulse Width,	tw	5 10 15	160 90 60	<u> </u>	ns
Clock Pulse Width,	t <sub>W</sub>	5 10 15	330 170 100	- - -	ns
Clock Frequency,	<sup>f</sup> CL	5 10 15	dc	1.2 <sup>-5</sup> 2.5 3.5	MHz
Clock Rise or Fall Time.	trCL or tfCL	5, 10,15	_	15	μς
Inhibit In Setup Time,	<sup>t</sup> su	5 10 15	100 40 20	_ _ _	ns
Inhibit In Removal Time,	<sup>‡</sup> REM	5 10 15	240 130 110		ns
Set Removal Time,	<sup>†</sup> REM	5 10 15	150 80 50	= * * * * * * * * * * * * * * * * * *	ns
Clear Removal Time,	<sup>t</sup> REM	5 10 15	60 40 30	_ _ _	ns



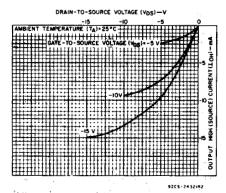


Fig. 5 — Minimum output high (source) current characteristics.

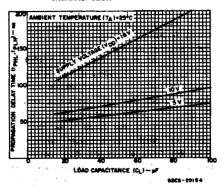


Fig. 6 — Typical propagation delay time as a function of load capacitance (Clock or Strobe to Out).

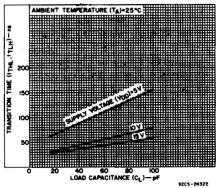


Fig. 7 — Typical transition time as a function of load capacitance.

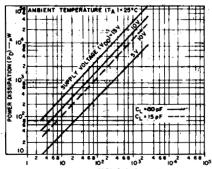


Fig. 8 — Typical dynamic power dissipation as a function of input frequency.

## CD4089B Types

## DYNAMIC ELECTRICAL CHARACTERISTICS at T<sub>A</sub> = 25°C; Input t<sub>r</sub>, t<sub>f</sub> = 20 ns, C<sub>L</sub> = 50 pF, R<sub>L</sub> = 200 k $\Omega$

CHARACTERISTIC	TES					UNITS
		V <sub>DD</sub>	<u></u>	LIMITS	3	014110
		v	Min.	Тур.	Max.	
Propagation Delay Time, tpHL, tpLH	-	5	_	110	220	
Clock to Out	İ	10	_	55	110	
		15		45	90	ns
		5	-	150	300	
Clock or Strobe to Out		10	-	75	150	
		15		60	120	
Clock to Inhibit Out		5 10	-	360	720	
High Level to Low Level		15	-	160 110	320 220	ns
		5		250	500	
Low Level to High Level		10	_	100	200	ns
		15	-	75	150	
		5	_	380	760	
Clear to Out		10	-	175	350	ns
· · · · · · · · · · · · · · · · · · ·		15		130	260	
		5		300	600	
Clock to "9" or "15" Out		10	-	125	250	ns
		15		90	180	
Cascade to Out		5	_	90	180	
Cascade to Out		10 15	_ :	45 35	90 70	ns
***				160		
Inhibit In to Inhibit Out		5 10	_	75	320 150	
		15	_	55	110	
:		5		330	660	ns
Set to Out		10	_	150	300	
		15		110	220	
·		5	-	100	200	
Transition Time, <sup>t</sup> THL <sup>, t</sup> TLH		10	-	50	100	ns
**		15	-	40	80	
		5	1.2	2.4	- 1	
Maximum Clock Frequency, fCL		10	2.5	5	-	MHz
	-	15	3.5	7		
Minimum Clock Pulse Width, tw		10	_	165 85	330 170	ne
William Glock Laise Width, 144		15		50	100	ns
		5	_		15	
Clock Rise or Fall Time, t <sub>rCL</sub> , t <sub>fCL</sub>		10	. —	<u> </u>	15	μs
· · <del></del> 1		1	1	l _	15	
<u></u>		15	_			
	·	15 5		80	160	
Minimum Set or Clear Pulse Width, t <sub>W</sub>		10	1 -	45	160 90	ns
Minimum Set or Clear Pulse Width, t <sub>W</sub>		5 10 15	- -	45 30	160	ns
		5 10 15 5	- - -	45 30 50	160 90 60 100	
Minimum Set or Clear Pulse Width, t <sub>W</sub>		5 10 15 5 10		45 30 50 20	160 90 60 100 40	ns
Minimum Inhibit-In Setup Time, t <sub>SU</sub>		5 10 15 5 10 15		45 30 50 20 10	160 90 60 100 40 20	
		5 10 15 5 10		45 30 50 20	160 90 60 100 40	

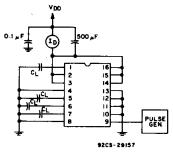


Fig. 9 — Dynamic power dissipation test circuit.

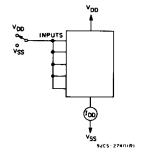


Fig. 10 - Quiescent device current test circuit.

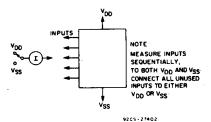


Fig. 11 - Input-current test circuit.

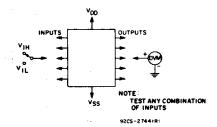
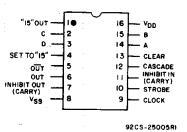


Fig. 12 - Input-voltage test circuit.



TOP VIEW
TERMINAL ASSIGNMENT

## CD4089B Types

DYNAMIC ELECTRICAL CHARACTERISTICS at T\_A = 25°C (cont'd) Input t\_r, t\_f = 20 ns, C\_L = 50 pF, R\_L = 200 k $\Omega$ 

CHARACTERISTIC	TEST CONDITIO	NS						
		VDD		LIMITS				
	. +	V	Min.	Тур.	Max.			
Minimum Set Removal Time, tREM	1	5 10 15	-	75 40 25	150 80 50	ns		
Minimum Clear Removal Time, tRE	м	5 10 15	- - -	30 20 15	60 40 30	ns		
Input Capacitance, C <sub>IN</sub>	Any Input	-	:- "	5	7.5	pF		

STATIC	FI FCTRICAL	CHARACTERISTICS
317116	ELECINICAL	CHARACTERISTICS

CHARAC- TERISTIC	CON	DITIO	NS	LIN	NITS AT	INDICAT	ED TEM	PERAT		C)	<b>N</b> – T
	V <sub>O</sub>	V <sub>IN</sub>	V <sub>DD</sub>	55	40	+85	+125	Min.	+25 Typ.	Max.	S
		0.5	5	5	5	150	150		0.04	5	┝
Quiescent Device	_	0,10	10	10	10	300	300		0.04	10	١.
Current,	_	0,15	15	20	20	600	600	_	0.04	20	μΑ
IDD Max.	_	0,20	20	100	100	3000	3000	_	0.08	100	l
	0.4	0,5	5	0.64	0.61	0.42	0:36	0.51	1	_	Н
Output Low (Sink) Current	0.5	0,10	10	1.6	1.5	1.1	0.9	1.3	2.6	-	
OL Min.	1.5	0,15	15	4.2	4	2.8	2.4	3.4	6.8	_	
	4.6	0,5	5	-0.64	-0.61	-0.42	-0.36	-0.51	-1	_	m
Output High (Source) Current, <sup>1</sup> OH <sup>Min</sup> .	2.5	0,5	5	-2	-1.8	-1.3	-1.15	-1.6	+3.2	_	
	9.5	0,10	10	1.6	-1.5	-1.1	-0.9	-1.3	-2.6	-	
	13.5	0,15	15	-4.2	-4	-2.8	- 2.4	-3.4	-6.8		
Output Voltage:	_	0,5	5		0	.05		0	0.05	T	
Low-Level,	_	0,10	10		0	.05		0	0.05		
VOL Max.	_	0,15	15		0	.05		-	0	0.05	l
Output	-	0,5	-5		4	95		4.95	5	_	1
Voltage:	_	0,10	10		9	.95	,	9.95	10	_	1
High-Level, VOH <sup>Min.</sup>	-	0,15	15		14	.95		14.95	15	-	1
	0.5,4.5	_	5			1.5		-	_	1.5	Г
Input Low Voltage	1,9	-	10			3		_	<u> </u>	3	]
VIL Max.	1.5,13.5	1	15			4		-		4	Ì١
Input High	0.5,4.5	. –	5			3.5		3.5	. –	-	
Voltage,	1,9	_	10			7		7	-	_	
VIH Min.	1.5,13.5	_	15			11		11		-	L
Input Current		0,18	18.	±0.1	±0.1	±1	±1.	. –	±10-5	±0.1	μ

	TRUTH TABLE													
						INPUT	S				OUTPL	ITS		
	Number of Pulses or Input Logic Level (0 = Low; 1 = High; X = Don't Care)										Number of Pulses or Output Logic Level (L = Low; H = High)			
D	С	В	A	CLK	INH IN	STR	CAS	CLR	SET	OUT	OUT	INH OUT	"15" OUT	
0	0	0	0	16	0	0	0	0	0	L	Н	1	1	
0	0	0	1	16	0	0	0	0	0	1	1	1	1 1	
0	0	1	0	16	0	0	0	0	0	2	2	1	1.	
0	0	1	1	16	0	0	0	0	0	3	. 3	1.	1	
0	1	0	0	16	0	0	0	0	0	4	4	1	1	
0	1	0	1	16	0	0	0	0	0	5	5	1	] 1 [	
0	1	1	0	16	0	0	0	0	0	6	6	1	1	
0	1	1	1	16	0	0	0	0	0	7	7	1	1	
1	0	0	0	16	0	0	0	0	0	8	8	1	1	
1	0	0	1	16	0	0	0	0	0	9	9	1	1	
1	0	1	0	16	0	. 0	0	0	0	10	10	1	1	
1	0	1	1	16	0	0	0	0	0	. 11	11	. 1	1	
1	1	0	0	16	0	0	9	0	0	12	12	1	1	
1	1	0	1	16	0	0	0	0	0	13	13	1	1	
1	1	1	0	16	0	0	0	0	0	14	14	1	1	
1	1	1	1	16	0	0	0	0	0	15	15	1	1	
x	x	x	х	16	1	0	- O	0	0	†	t	н	†	
X	X	х	X	16	0	1	0	0	0	L	н	1	1	
Х	X	х	X	16	0	0	1	0	0	н	*	1	1	
1	х	Х	Х	16	0	0	0	1	0	16	16	Н	L	
0	Х	Х	X	16	0	0	0	1	0	L	Н	н	L	
X	X	Х	X	16	0	-0	0	X	1	L	н	L	н [	

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CLOCK	92 CS - 25008

Fig. 13 – Two CD4089B's cascaded in the "Add" mode with a preset number

of 189 
$$\left(\frac{11}{16} + \frac{13}{256} = \frac{189}{256}\right)$$

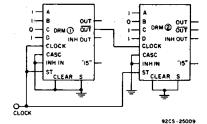


Fig. 14 —Two CD4089B's cascaded in the "Multiply" mode with a preset number

of 143 
$$\left(\frac{11}{16} \times \frac{13}{16} = \frac{143}{256}\right)$$
.

\* Output same as the first 16 lines of this truth table (depending on values of A, B, C, D).

## 

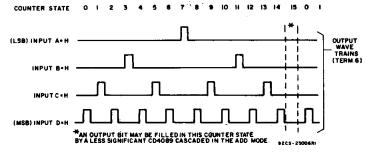
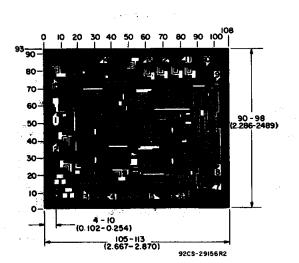


Fig. 15 - Timing diagram.

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils ( $10^{-3}$  inch).



Dimensions and Pad Layout for CD4089BH

<sup>†</sup> Depends on internal state of counter.

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#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
CD4089BE	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD4089BE	Samples
CD4089BEE4	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD4089BE	Samples
CD4089BNSR	LIFEBUY	SO	NS	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4089B	
CD4089BPWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM089B	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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## **PACKAGE OPTION ADDENDUM**

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

## **PACKAGE MATERIALS INFORMATION**

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## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD4089BNSR	so	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
CD4089BPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

## **PACKAGE MATERIALS INFORMATION**

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## \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD4089BNSR	SO	NS	16	2000	356.0	356.0	35.0
CD4089BPWR	TSSOP	PW	16	2000	356.0	356.0	35.0

## **PACKAGE MATERIALS INFORMATION**

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## **TUBE**



\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CD4089BE	N	PDIP	16	25	506	13.97	11230	4.32
CD4089BE	N	PDIP	16	25	506	13.97	11230	4.32
CD4089BEE4	N	PDIP	16	25	506	13.97	11230	4.32
CD4089BEE4	N	PDIP	16	25	506	13.97	11230	4.32



SOP



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.



SOF



## NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOF



#### NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.





SMALL OUTLINE PACKAGE



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



## **MECHANICAL DATA**

## NS (R-PDSO-G\*\*)

## 14-PINS SHOWN

## PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



## N (R-PDIP-T\*\*)

## PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



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